

SEMITOP®E2

Half-Bridge (Full SiC)

SK250MB120CR03TE2

Features*

- Optimized design for superior thermal performance
- Extremely low inductance design
- Press-Fit contact technology
- 1200V Planar Gen3 SiC MOSFET
- Simple to drive with +15V gate voltage
- Optimized switching stability thanks to module integrated gate resistors
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

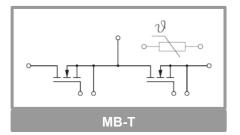
- Switched Mode Power Supplies
- Energy Storage Systems
- Electric Vehicle charging
- UPS
- Solar

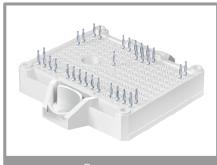
Remarks

- Recommended T_{jop} = -40°C...+150°C
- Recommended turn-off / turn-on gate voltage V_{GS} = -4...0/+15V

Absolute Maximum Ratings						
Symbol	Conditions		Values	Unit		
MOSFET						
V _{DSS}	T _j = 25 °C		1200	V		
1_	HPTP / HP-PCM Tj = 175 °C	T _s = 25 °C	267	Α		
I _D		T _s = 70 °C	223	Α		
I _{DM}	Pulse witdh t _p limited by T _{vjmax}		720	Α		
V _{GS}	Transient Gate - Source voltage (t<100ns)		-8 19	V		
Tj			-40 175	°C		
Integrate	d body diode					
I _{FM}	Pulse width t _p limited by T _{vjmax}		720	Α		
I _{FSM}	$t_p = 10 \text{ ms}, \sin 180^\circ, T_j = 150 ^\circ\text{C}$		1076	Α		

Absolute Maximum Ratings						
Symbol	Conditions	Values	Unit			
Module						
I _{t(RMS)}	ΔT _{terminal} at PCB joint = 30 K, per pin	30	Α			
T _{stg}	module without TIM	-40 125	°C			
V _{isol}	AC, sinusoidal, t = 1 min	2500	V			





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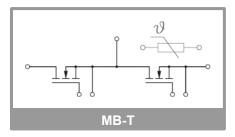
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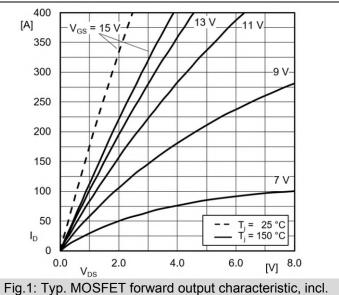
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
MOSFET						
V _{(BR)DSS}	V _{GS} = 0 V, I _D = 0.6 mA, T _j = 25 °C		1200			V
V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 69 I$	mA, T _j = 25 °C	1.8	2.5	3.6	V
I _{DSS}	$V_{GS} = 0 V, V_{DS} = 12$	200 V, T _j = 25 °C			0.6	mA
I _{GSS}	V _{DS} = 0 V, V _{GS} = 15 V, T _j = 25 °C				400	nA
В	V _{GS} = 15 V,	T _j = 25 °C		5.3	7.2	mΩ
R _{DS(on)}	I _D = 248 A, chiplevel	T _j = 150 °C		8.3		mΩ
C _{iss}	$V_{GS} = 0 V$	f = 0.1 MHz		20400		pF
Coss	$V_{DS} = 1000 \text{ V},$	f = 0.1 MHz		780		pF
C _{rss}	$T_j = 25 ^{\circ}C$	f = 0.1 MHz		60		pF
Q_G	$V_{GS} = -415V, V_{DI}$	$_{\rm D}$ = 800V, $I_{\rm D}$ = 248 A		708		nC
R _{Gint}	T _j = 25 °C			2.3		Ω
t _{d(on)}	V _{DD} = 600 V	T _j = 150 °C		49		ns
$t_{d(off)}$	$\begin{array}{l} I_D = 240 \text{ A} \\ V_{GS} = -4/+15 \text{ V} \\ R_{G \text{ on/off}} = 0.5 \Omega \\ \text{di/dt}_{off} = 15 \text{ kA/µs} \\ \text{di/dt}_{on} = 22 \text{ kA/µs} \\ \text{dv/dt} = 29 \text{ kV/µs} \\ L_s = 5 \text{ nH} \end{array}$	T _j = 150 °C		120		ns
t _r		T _j = 150 °C		17		ns
t _f		T _j = 150 °C		29		ns
E _{on}		T _j = 150 °C		2.97		mJ
E _{off}		T _j = 150 °C		2.57		mJ
R _{th(j-s)}	per MOSFET, HPTP / HP-PCM			0.19		K/W
Integrate	d body diode	·				
\ _ \ /	-I _D = 124 A	T _j = 25 °C		4.6		V
$V_F = V_{SD}$	V _{GS} = -4 V chiplevel	T _j = 150 °C		4.3		V
\/ -\/	chiplevel	T _j = 25 °C		3.8		V
V _{F0} - V _{SD0}		T _j = 150 °C		3.6		V
r - r	chiplevel	T _j = 25 °C		6.4		mΩ
$r_F = r_{SD}$		T _j = 150 °C		5.6		mΩ
t _{rr}	V _{DD} = 600 V	T _j = 150 °C		40		μs
Q _{rr}	$-I_D = 240 \text{ A}$ $V_{GS} = -4 \text{ V}$ $R_{Gon} = 0.5 \Omega$ $di/dt_{off} = 23 \text{ kA/}\mu\text{s}$	T _j = 150 °C		6.7		μC
Irr		T _j = 150 °C		337		Α
Err		T _j = 150 °C		2.21		mJ

Characteristics						
Symbol	Conditions	min.	typ.	max.	Unit	
Module						
L _{CE}			6		nΗ	
Ms	to heatsink	1.6		2.3	Nm	
W	weight		35		g	

Characteristics						
Symbol	Conditions	min.	typ.	max.	Unit	
Temperature Sensor						
R ₁₀₀	T _r = 100 °C	493 ± 5%			Ω	
B _{100/125}	$R_{(T)} = R_{100} * \exp[B_{100/125} * (1/T-1/T_{100})], T[K];$		3550 (± 2%)		K	





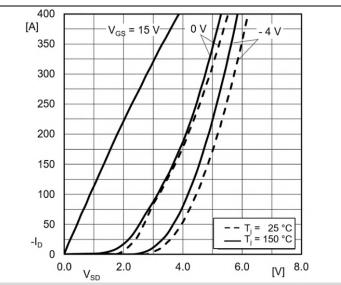
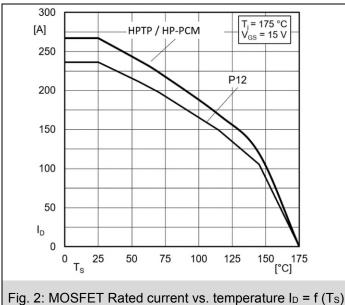


Fig. 1a: Typ. MOSFET reverse output characteristic, incl.



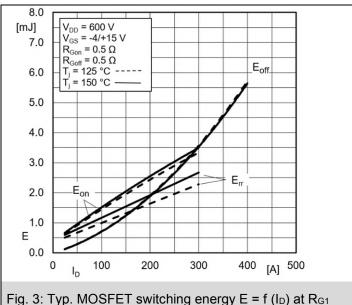
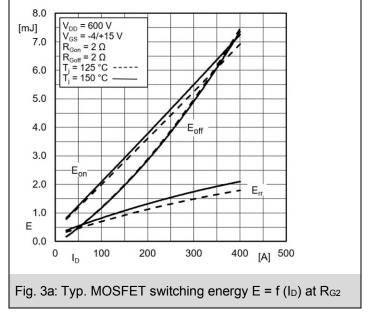
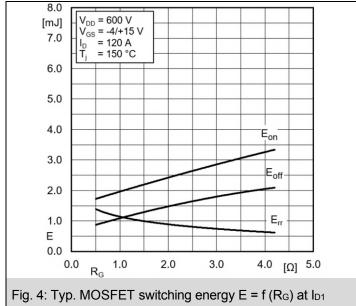
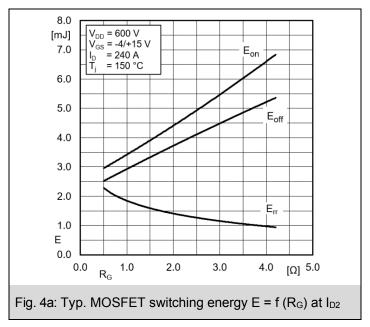
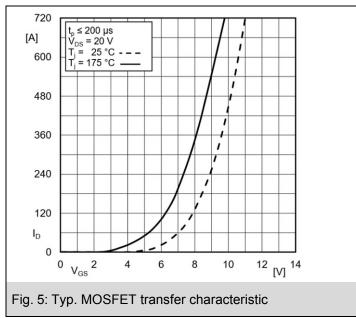


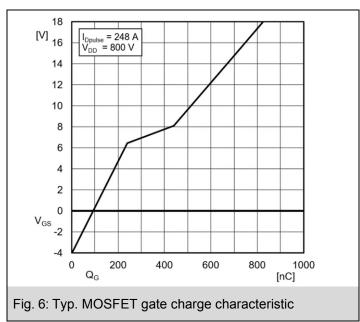
Fig. 3: Typ. MOSFET switching energy E = f (I_D) at R_{G1}

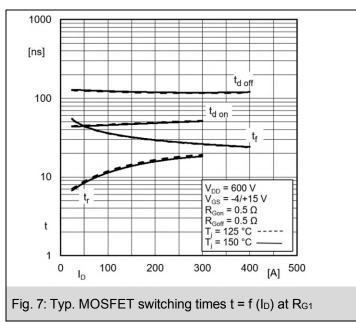


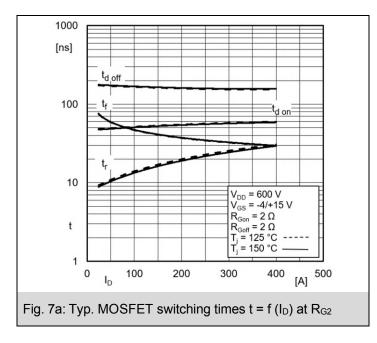


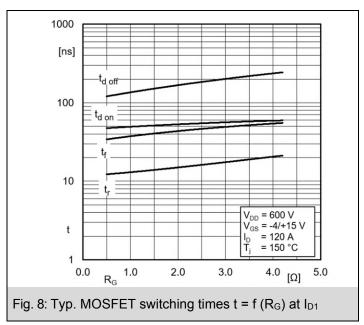


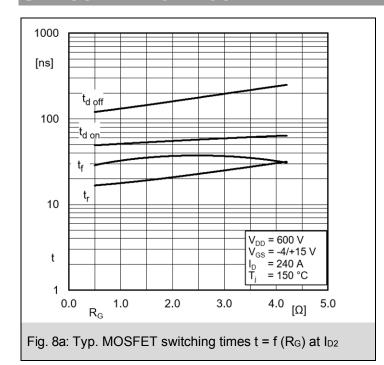


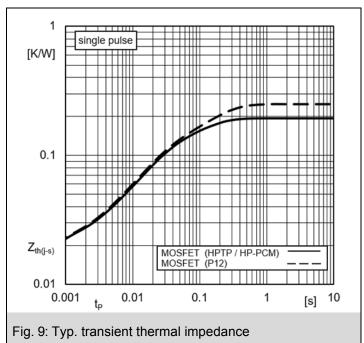












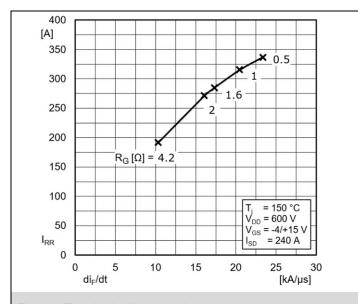


Fig. 10: Typ. body diode peak reverse recovery current $I_{\text{RR}} = f\left(\text{di}_{\text{F}}/\text{dt}\right)$

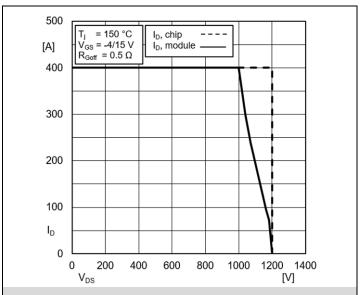
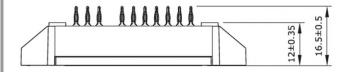
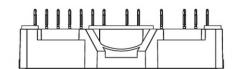
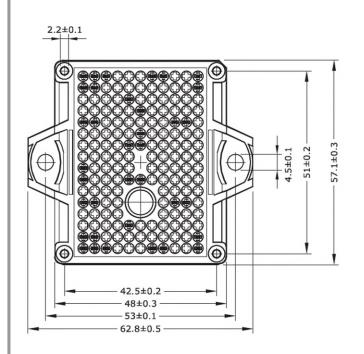
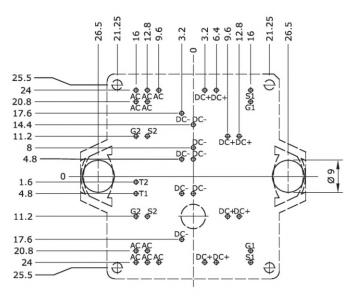


Fig. 11: MOSFET Reverse Bias Safe Operating Area (RBSOA)



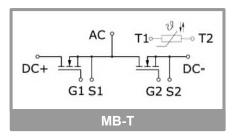






- Pin-Grid 3.2 mm
- Tolerance of PCB hole pattern Φ Ø0.1
- Diameters of drill $\not \odot$ 1.15mm
- Copper thickness in hole 25 50 μm
- Hole specification for contacts: refer to SEMITOP E1/E2 Mounting Instruction

Pinout and Dimensions



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

*IMPORTANT INFORMATION AND WARNINGS

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